



SIGC42T120CS2

IGBT Chip in NPT-technology

FEATURES:

- 1200V NPT technology 175µm chip
- low turn-off losses
- short tail current
- positive temperature coefficient
- easy paralleling

This chip is used for:

• IGBT Modules

Applications:

drives, SMPS, resonant applications



Chip Type	V _{CE}	I _{Cn}	Die Size	Package	Ordering Code
SIGC42T120CS2	1200V	25A	6.59 x 6.49 mm ²	sawn on foil	Q67050- A4086-A003

MECHANICAL PARAMETER:

6.59 x 6.49	mm ²			
2 x (2.18 x 1.58)				
1.06 x 0.65				
42.8 / 33.5				
175	μm			
150	mm			
90	grd			
334 pcs				
Photoimide				
3200 nm Al Si 1%				
1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding				
electrically conductive glue or solder				
AI, <500μm				
Reject Ink Dot Size Ø 0.65mm; max 1.2mm				
store in original container, in dry nitrogen, < 6 month				
	2 x (2.18 x 1.58) 1.06 x 0.65 42.8 / 33.5 175 150 90 334 pcs Photoimide 3200 nm Al Si 1% 1400 nm Ni Ag –system suitable for epoxy and soft solder die botoelectrically conductive glue or solder Al, <500μm Ø 0.65mm; max 1.2mm			



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MAXIMUM RATINGS:

Parameter	Symbol	Value	Unit
Collector-emitter voltage	V _{CE}	1200	V
DC collector current, limited by T _{jmax}	I _C	25	А
Pulsed collector current, t _p limited by T _{jmax}	I _{cpuls}	50	А
Gate emitter voltage	V _{GE}	±20	V
Operating junction and storage temperature	T_j , T_{stg}	-55 + 150	°C

STATIC CHARACTERISTICS (tested on chip), T_j =25 °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
i didilictei		Conditions	min.	typ.	max.	
Collector-emitter breakdown voltage	$V_{(BR)CES}$	V_{GE} =0V , I_{C} = 1.5mA	1200			
Collector-emitter saturation voltage	V _{CE(sat)}	V _{GE} =15V, I _C =25A	2.7	3.2	3.7	V
Gate-emitter threshold voltage	$V_{\rm GE(th)}$	I _C =1mA , V _{GE} =V _{CE}	4.5	5.5	6.5	
Zero gate voltage collector current	I _{CES}	V _{CE} =1200V , V _{GE} =0V			150	μA
Gate-emitter leakage current	I _{GES}	V_{CE} =0V , V_{GE} =30V			120	nA

ELECTRICAL CHARACTERISTICS (tested at component):

Parameter	Symbol	Conditions	Value			Unit
raiametei	Symbol	Conditions	min.	typ.	max.	Ullit
Input capacitance	Ciss	$V_{CE}=25V$,	-	1.65		nF
Output capacitance	Coss	$V_{GE}=0V$,	-	0.25		
Reverse transfer capacitance	Crss	f=1MHz	-	0.11		

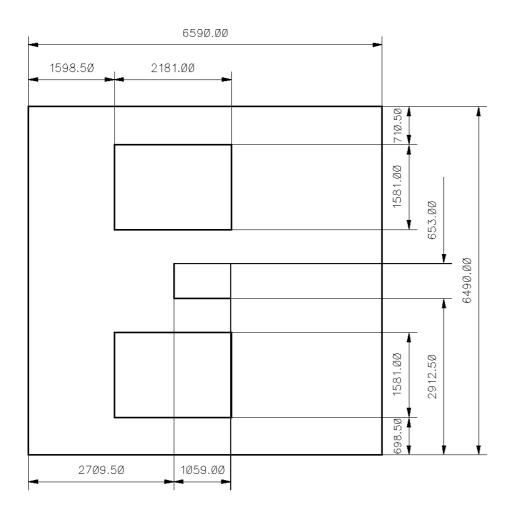
SWITCHING CHARACTERISTICS (tested at component), Inductive Load

Parameter	Symbol	Conditions	Value			Unit
raiametei	Symbol	Conditions	min.	typ.	max.	Oiiit
Turn-on delay time	$t_{d(on)}$	<i>T</i> _j =125°C	-	tbd		ns
Rise time	t _r	V _{CC} =600V,	-	tbd		
Turn-off delay time	$t_{d(off)}$	I _C =25A, V _{GE} =-15/15V,	-	tbd		
Fall time	t_{f}	$R_{\rm G}$ = 22 Ω	-	tbd		



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CHIP DRAWING:



1 mm

all measurements in um



Preliminary

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FURTHER ELECTRICAL CHARACTERISTICS:

This chip data sheet refers to the device data sheet	tbd				
DESCRIPTION:					
AQL 0,65 for visual inspection according to failure catalog					
Electrostatic Discharge Sensitive Device according to MIL-STD 883					
Test-Normen Villach/Prüffeld					

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